Application/Control No. O9/420,719 Applicant(s)/Patent Under Reexamination MIYASHITA ET AL. Examiner Kartic Padmanabhan Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,183,740	02-2001	Short et al.	424/94.6
	В	US-5,935,442	08-1999	Lihme et al.	210/656
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	Т					

NON-PATENT DOCUMENTS

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